



DESCRIPTION

P-channel Enhancement Mode Power MOSFET

FEATURES

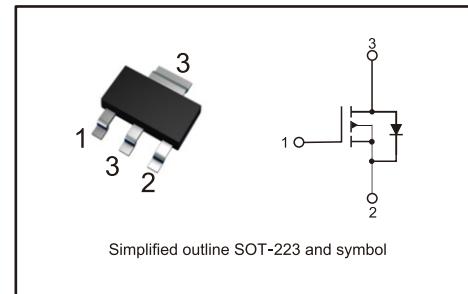
- Advanced Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- Lead free product is acquired

APPLICATION

- PWM Applications
- Load Switch
- Power Management

PINNING

PIN	DESCRIPTION
1	GATE
2	SOURCE
3	DRAIN



MAXIMUM RATINGS (Ta=25°C unless otherwise noted)

Parameter		Symbol	Value	Unit
Drain-Source Voltage		V _{DSS}	-60	V
Gate-Source Voltage		V _{GSS}	±20	V
Continuous Drain Current	T _a =25°C	I _D	-5	A
	T _a =100°C		-3	A
Pulsed Drain Current(Note1)		I _{DM}	-20	A
Power Dissipation	T _a =25°C	P _D	1.5	W
Thermal Resistance-Junction to Ambient(Note2)	T _a =25°C	R _{θJA}	81	°C/W
Operating Junction Temperature		T _j	-55 to +150	°C
Storage Temperature		T _{stg}	-55 to +150	°C



ELECTRICAL CHARACTERISTICS(Ta=25°C unless otherwise noted.)

Parameter	Symbol	Test conditions	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D = -250uA	-60			V
Drain-Source Leakage Current	I _{DS}	V _{DS} = -60V, V _{GS} = 0V			-1	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V			±0.1	uA
On Characteristics						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = -250uA	-1	-1.5	-2.5	V
Static Drain-Source On-State Resistance(Note3)	R _{DS(on)}	V _{GS} = 10V, I _D = -5A		90	120	mΩ
		V _{GS} = 4.5V, I _D = -3A		110	145	
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{DS} = -25V V _{GS} = 0V f = 1MHz		305		pF
Output Capacitance	C _{oss}			66		
Reverse Transfer Capacitance	C _{rss}			7		
Total Gate Charge	Q _g	V _{DS} = -30V V _{GS} = -10V I _D = -5A		5		nC
Gate-Source Charge	Q _{gs}			0.97		
Gate-Drain Charge	Q _{gd}			0.72		
Switching Characteristics						
Turn-On Delay Time	t _{d(on)}	V _{DD} =-30V, R _{GEN} =5Ω, V _{GS} =-10V, I _D =-2A,		7		ns
Turn-On Rise Time	t _{rr}			8		
Turn-Off Delay Time	t _{d(off)}			16		
Turn-Off Fall Time	t _f			4		
Body Diode Characteristics						
Drain-Source Diode Forward Voltage	V _{SD}	I _S = -3A, V _{GS} = 0V			1.2	V
Diode Forward Current	I _S				-5	A
Reverse Recovery Charge	t _{rr}	dI _{SD} /dt=100A/μs I _{SD} =-4A		25		nS
Reverse Recovery Time	Q _{rr}			31		nC

Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

2. R_{θJA} is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB

3. Pulse Test: Pulse Width≤300μs, Duty Cycle≤0.5%.



Test Circuit

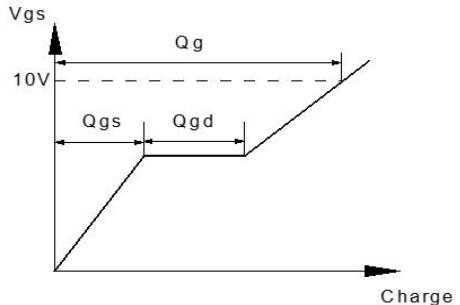
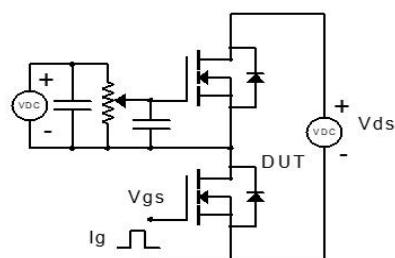


Figure 1: Gate Charge Test Circuit & Waveform

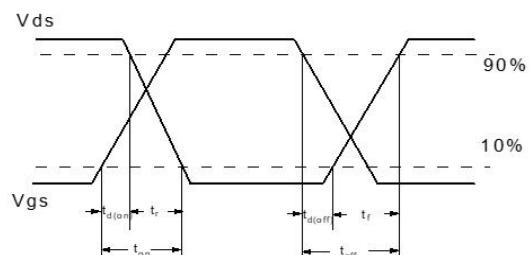
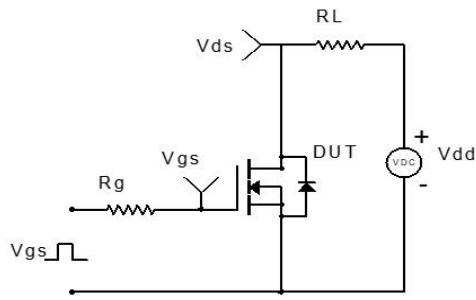


Figure 2: Resistive Switching Test Circuit & Waveform

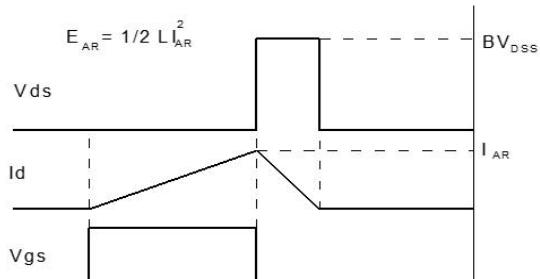
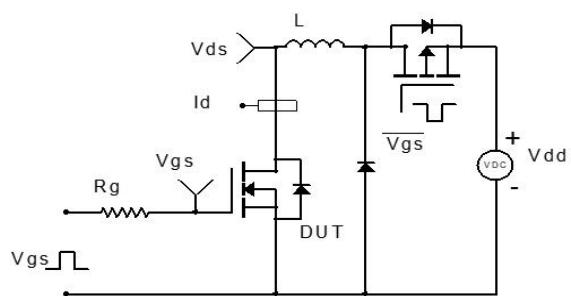


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

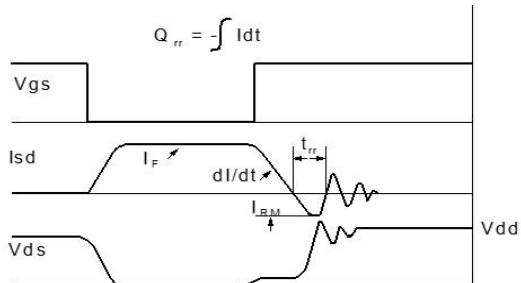
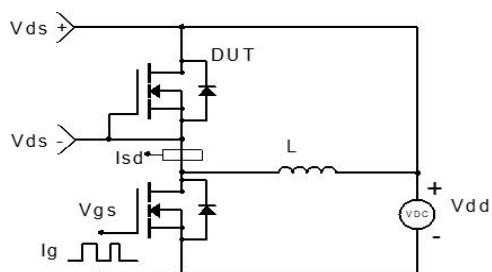
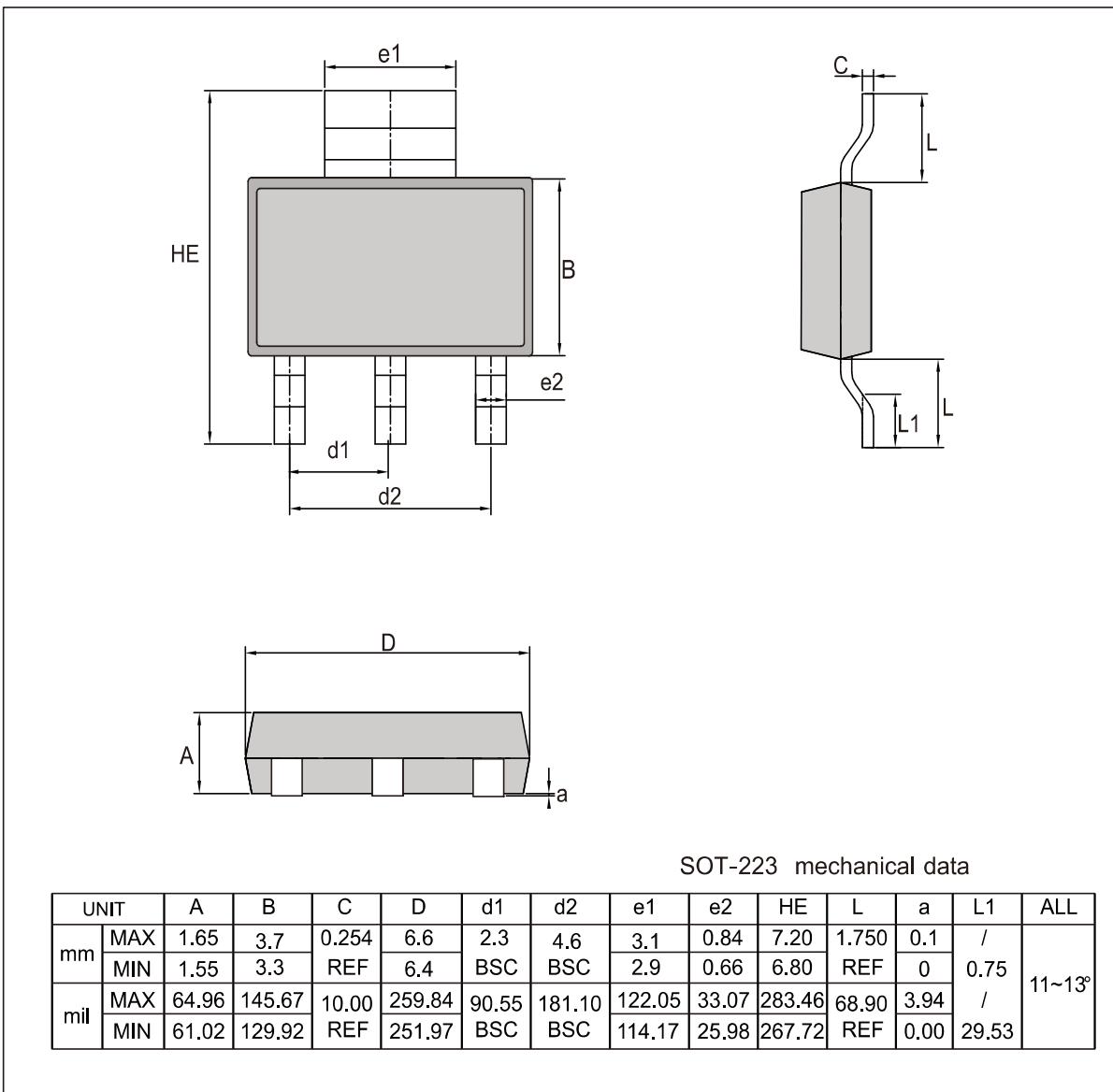


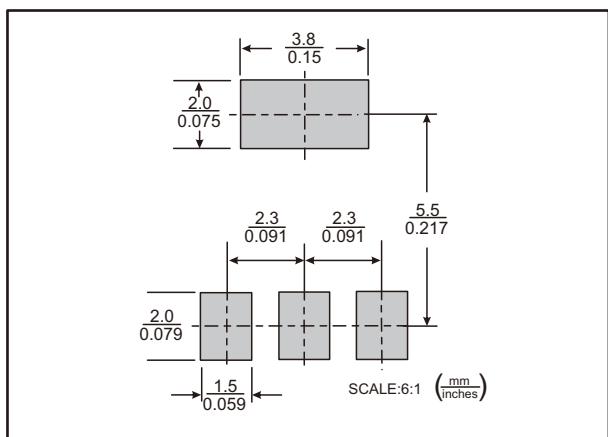
Figure 4: Diode Recovery Test Circuit & Waveform



SOT-223 Package Outline Dimensions



The recommended mounting pad size



Marking

Type number	Marking code
PM5P60HWK	KSH



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